Thermoelectric studies of electronic properties of ferromagnetic GaMnAs layers

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Abstract. Thermoelectric power, electrical conductivity, and high field Hall effect were studied over a broad temperature range in ferromagnetic Ga1-xMnxAs epitaxial layers (0.015 ≤ x ≤ 0.06). Thermoelectric power analysis gives information about carrier transport mechanisms in layers with both metallic and non-metallic types of conductivity and allows determination of the Fermi energy and carrier concentration. At high temperatures (T > 70 K), the thermoelectric power in GaMnAs linearly increases with increasing temperature. That indicates the presence of a degenerate hole gas with the Fermi energy EF = 220 ± 25 meV, nearly independent of Mn content (for 0.02 ≤ x ≤ 0.05). At lower temperatures, GaMnAs layers with metallic-type conductivity show an additional contribution to the thermoelectric power with the maximum close to the Curie temperature.

Keywords: thermoelectric power, ferromagnetic Ga1-xMnxAs, Curie temperature.

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1. Introduction

Among magnetic semiconductors suitable for future spintronic applications, the ferromagnetic layers of GaMnAs remain the most important material system [1-5]. Ferromagnetic state in GaMnAs is induced by an extremely high concentration of conducting holes, as shown in Zener or Ruderman-Kittel-Kasuya-Yosida interaction mean field theoretical models of ferromagnetic transition [5-8]. The electronic parameters of the system, such as Fermi wavevector, carrier effective mass and concentration are the physical factors determining not only the transition temperature but also the magnetic state of the system. An example of the direct influence of electronic parameters of GaMnAs on its magnetic properties is the control of the direction of the easy axis of magnetization achieved for various concentrations of conducting holes [9-11]. Ferromagnetic GaMnAs layers are grown by low-temperature molecular beam epitaxy (LT-MBE) technique, which allows to obtain monocrystalline single phase layers with Mn content up to 9 at.% [1, 12-15]. These layers constitute a system which is strongly disordered in both magnetic (random site diluted magnetic system) and electronic (very strong compensation of Mn acceptor centers by donors) subsystems. It results in extremely intriguing electronic properties of this material revealing both a semi-metallic character of conductivity (usually for 0.03 ≤ x ≤ 0.055) and an insulating one observed both for higher and lower Mn content [1, 5, 10, 16-18]. In GaMnAs layers, Mn ions serve as the source of local magnetic moments as well as electrically active acceptor centers generating the very high concentration of conducting holes of the order of 10^{20} cm^{-3}. The underlying mechanism of ferromagnetic transition and magnetotransport effects is the p-d exchange coupling between the local magnetic moments of Mn ions and spins of conducting holes. It also is the driving mechanism for electrically or optically detected spintronic effects [1, 10, 19-21]. The LT-MBE GaMnAs layers are known to be strongly compensated by double-donor centers: interstitial Mn ions as well as As antisites [14, 22-25]. The control over this heavy background doping achieved recently via thermal annealing...
procedures resulted in a substantial increase of the ferromagnetic Curie temperature, up to about 170 K [23–29]. Although intriguing and challenging scientifically as well as important for achieving a practical control of ferromagnetic transition temperature and magnetic anisotropy in GaMnAs, the electronic properties of this material are relatively poorly understood. It is related to the strong limitations for the use of standard magneto-transport and magneto-optical methods in materials with very low carrier mobilities and a large electrical compensation as well as a strong band tailing and other disorder driven electronic effects encountered in LT-MBE GaMnAs layers [30, 31].

In this work, we examine the electronic properties of GaMnAs layers by studying the electron transport effect—the thermoelectric power (Seebeck effect). This experimental method proved to be very successful in the studies of electronic parameters of various metallic and semiconducting materials. It is particularly useful in the studies of strongly disordered electronic systems exhibiting variety of electron transport mechanisms, involving conduction or valence band states as well as impurity bands or hopping mechanism [32, 33]. The analysis of the temperature dependence of the thermoelectric power allows for the determination of the Fermi energy and (within a certain model of the band structure) of carrier concentration or the effective mass of density of states. We are interested in both determining these basic electronic parameters of GaMnAs and studying the influence of the ferromagnetic transition on electronic transport effects. Therefore, our experimental studies cover a broad temperature region that includes both paramagnetic and ferromagnetic ranges of temperatures. For this study, we selected a set of thick (up to 3 µm), high quality monocrystalline layers of Ga_{1-x}Mn_xAs grown by LT-MBE technique on GaAs (001) semi-insulating substrates with the Mn content (0.015 ≤ x ≤ 0.06) covering both the layers with metallic and non-metallic characters of electrical conductivity. We show that at high temperatures (T ≥ 70 K) the temperature dependence of thermoelectric power in GaMnAs layers is of quasi-linear character expected for a strongly p-type doped degenerate semiconductor. The analysis of this standard (diffusion) contribution to the thermoelectric power allowed to evaluate the Fermi energy (E_F = 0.22 eV) and carrier concentration (p = 2·10^{20} cm^{-3}), which turned out to be very weakly dependent on the content of Mn ions. At lower temperatures, the layers of GaMnAs with the metallic type of conductivity reveal an additional contribution to the thermoelectric power attributed to the ferromagnetic transition (Kasuya mechanism [34]). At low temperatures, we also observe a negative, temperature independent, contribution to the thermoelectric power assigned to the exchange thermoelectric power (Kondo mechanism [35]). In GaMnAs layers exhibiting insulating properties, the additional Δα ∝ ΔE / k_B T – type contribution to the thermoelectric power is observed at low temperatures with the activation energy (ΔE = 1 meV) characteristic for hopping conduction mechanisms.

The paper is organized as follows. In Section 2, after giving the information on the technological details of growth as well as structural, electrical, and magnetic characterization of the layers, we present the results of the experimental studies of the temperature dependence of the thermoelectric power and high field Hall effect in a series of GaMnAs layers covering a broad range of Mn compositions. The analysis of the experimental observations, covering high temperature as well as low temperature (both paramagnetic and ferromagnetic) regions, is given in Section 3. In this section, we also discuss the physical mechanisms likely to contribute to thermoelectric effects in GaMnAs and perform the quantitative analysis of the experimental data on the thermoelectric power in GaMnAs at high temperatures. It results in determination of the Fermi energy and conducting hole concentration in the layers. The paper is summarized in Section 4.

2. Growth, characterization, and transport measurements

The monocrystalline epitaxial layers of Ga_{1-x}Mn_xAs (0.015 ≤ x ≤ 0.065, 0.3–3 µm thick) were grown by the low-temperature (LT) molecular beam epitaxy (MBE) technique on semi-insulating GaAs (001) substrates with a buffer layer of high-temperature MBE GaAs (with the thickness of 0.1–0.2 µm). Due to the technological regime applied during the MBE growth, the layer of GaMnAs and the GaAs buffer layer are separated by an ultrathin (with thickness of about 4 nm) n-type GaAs layer grown by LT MBE. The GaMnAs layers were grown at the substrate temperature 230 °C by using the effusion cells for Ga, Mn, and As_2 with the ratio of As_2 to Ga fluxes of about 2. The layers were not post-growth annealed. The list of the samples investigated in this work is presented in Table. Further detailed information about the growth conditions and structural characterization of the layers is given in Refs. 13 and 14. In a relatively broad temperature range discussed in this work, a certain contribution to the electrical conductivity of the GaMnAs/GaAs heterostructure is expected not only from the top layer of GaMnAs (ρ = 10^{20} cm^{-3}, thickness d = 0.3–3 µm) but also from the buffer layers of GaAs grown by high-temperature (ρ = 10^{13}–10^{14} cm^{-3}, d = 0.1–0.2 µm) and low-temperature MBE GaAs (n-type, high resistivity, d = 4 nm) buffer. Therefore, we checked, applying the formulae for conductivity and thermoelectric power of a system of parallel conducting layers that in the structures studied in this work the conductivity and thermoelectric power contributions due to the buffer layers can be neglected [36]. This conclusion is confirmed by our experimental observations showing practically no difference between thermoelectric properties of GaMnAs layers with similar Mn content but a large (up to the factor of 10) difference of layer thickness.
The measurements of the magnetic susceptibility, $\chi$, were carried out over the temperature range 4.5-100 K by applying the ac magnetic field $H_{ac} = 5$ Oe at the frequency of $f = 625$ Hz. We found that all the investigated GaMnAs layers undergo ferromagnetic transition with the Curie temperature between $T_c = 30$ K (sample with 1.5 at.% of Mn) and $T_c = 60$ K (sample with 6 at.% of Mn). The transition is evidenced by a sharp increase of the magnetic susceptibility below a certain temperature as well as an observation of a peak in the $\chi(T)$ plot (Fig. 1). In some layers, the peak in the $\chi(T)$ dependence was observed at noticeably lower temperatures than those corresponding to the sharp increase of the susceptibility. In such a case, we show in Fig. 2 both of these characteristic temperatures. For the GaMnAs layer with the nominal Mn concentration of 6 at.%, we found two peaks in the $\chi(T)$ dependence (see Fig. 1). It may indicate that this layer is composed of two layers with Mn content of 6 at.% and about 1 at.%.

The resistivity (at zero magnetic field) was measured by the standard four probe method over the temperature range 4.2-300 K. As shown in Fig. 3, we observed both metallic and semiconducting character of electrical conductivity in GaMnAs layers in the low temperature limit. This effect is well known for LT-MBE GaMnAs layers. Usually, in unannealed layers, metallic character of conductivity is found in GaMnAs layers with Mn content between 3 and 5.5 at.%, whereas samples with Mn content both below 3 at.% and above 5.5 at.% behave (in the low temperature limit) as semiconductors. The ferromagnetic transition in GaMnAs can be detected electrically as a characteristic feature (a maximum or a kink) on the temperature dependence of the resistivity. The effect is believed to originate from the scattering on the thermodynamic fluctuations of the magnetic subsystem of Mn ions and is expected to have the maximum at the Curie temperature. We found similar behavior in our layers, as shown in Fig. 3. The ferromagnetic transition temperatures determined in such a way correspond well to the maxima observed experimentally on the temperature dependence of magnetic susceptibility.
Electrical properties of the same layers were also studied by the high field dc Hall effect and magnetoresistance measurements in order to provide the control experiment for the comparison of the thermoelectric and the Hall effect measurements of the conducting hole concentration in GaMnAs. The Hall effect was measured for a series of the samples of GaMnAs at the temperature $T = 1.1$ K by applying a magnetic field up to 20 T. The low temperature and very high magnetic fields are essential in this experiment, because one needs to saturate magnetically the layers in order to reveal the contribution of the ordinary Hall effect on a strong background of the anomalous Hall effect [16]. Although 5 layers of GaMnAs with different Mn content ($x = 0.015, 0.03, 0.04, 0.045, \text{and} 0.05$) were experimentally studied, only for the layers with $x = 0.04$ and 0.045 (exhibiting metallic type of conductivity) we found that the ordinary Hall effect was observed in the high magnetic field (above 15 T). The concentration of conducting holes determined from the high field Hall effect measurements is shown in Table and in Fig. 5b. Considering the experimental limitations in determining the ordinary Hall effect in the presence of strong anomalous Hall effect and magnetoresistance, the agreement of the two methods is quite satisfactory.

3. Discussion

Our measurements of the thermoelectric power in GaMnAs layers clearly show that there exist two distinct temperature regions. At high temperatures (approximately for $T > 70$ K), all the layers studied show qualitatively similar linear increase of the thermoelectric power with increasing temperature. This is the standard behavior expected for strongly doped semiconductors with a degenerate hole gas. For the interpretation of the experimental results in this temperature region one can apply well known theory for the diffusion thermoelectric power. At low temperatures ($T < 70$ K), the temperature dependence of the thermoelectric power in GaMnAs layers qualitatively deviates from the standard expectations both for paramagnetic and ferromagnetic ranges of temperatures. These additional contributions to the thermoelectric power, characteristic for diluted magnetic systems, are indicative of spin dependent scattering and spin splitting in the band states, as shown in the models by Kondo [35] and Kasuya [34].

3.1. Thermoelectric power in the high temperature region

At high temperatures ($T > 70$ K), the temperature dependence of the thermoelectric power of all the
studied GaMnAs layers is quasi-linear. This behavior is qualitatively similar to the temperature dependence of the thermoelectric power observed in other heavily p-type doped semiconductor alloys, e.g. in SiGe:P [37]. To semi-quantitatively analyze the experimental data, we use the standard expression for the thermoelectric power in the heavily doped semiconductors with a parabolic energy dispersion relation. In the limit of high degeneration of electron or hole gas, it can be written as:

\[ \alpha_D = \frac{\pi^2 k_B^2}{3qE_F} (r + 3/2), \]

where \( r \) is the scattering parameter, \( E_F \) is the Fermi energy, \( k_B \) is the Boltzmann constant, and \( q \) is the charge of conducting carriers.

To calculate the Fermi energy, the scattering parameter \( r \) corresponding to the mechanism that limits the absolute value of the carrier mobility has to be specified. In our analysis, we take that this mechanism is the scattering by ionized impurities (\( r = 3/2 \)), the huge concentration of which (both Mn acceptors and compensating donor centers) is present in GaMnAs. The Fermi energies obtained within the approach described above are presented in Fig. 5a. For the samples with the metallic type of conductivity, the Fermi energy changes on molar rate \( \alpha \) only slightly, and it is found about 220 meV below the top of the valence band, whereas for the samples with the non-metallic type of conductivity, the Fermi energy value decreases by about 50 meV. Taking the effective mass of the density of states equal to \( m = 0.5 m_0 \) (the value frequently used in the analysis of electronic properties of GaMnAs [1, 18]), we obtain the concentration of conducting holes presented in Fig. 5b. It agrees well with the high field Hall effect measurements made for these layers.

The weak dependence of the concentration of conducting holes on Mn content, presented in Fig. 5a, can be qualitatively explained by taking into account the presence of very high concentrations of two types of compensating deep donor centers in LT-MBE GaMnAs layers. In GaMnAs, it is observed that despite the presence of a very high (of the order of \( 10^{18} \) cm\(^{-3} \)) concentration of Mn acceptor centers the layers with Mn content lower than about 1 at.% exhibit the non-metallic type of conductivity and become highly resistive upon lowering temperature. It is due to the compensation of Mn acceptors by native defects (As\(_{Ga}\) antisites), which are deep double donor centers well known in LT-MBE GaAs. Upon further increasing Mn concentration, the metallic p-type conductivity is achieved with conducting hole concentration of the order of \( 10^{17} \) cm\(^{-3} \). For the Mn content exceeding about 5 at.% the efficiency of the p-type doping with Mn is gradually reduced. It is due to the appearance of an increasing concentration of Mn ions occupying lattice interstitial positions; in that case Mn is a double charged donor center. It eventually leads to a decrease in the conducting hole concentration.

In our quantitative analysis, we used theoretical results developed for the case of a degenerate semi-conductor system with a band-type conductivity mechanism. The only band structure parameter needed in this approach is the density-of-states effective mass. This approach is expected to be valid for parabolic, anisotropic (also multiple degenerate) bands. However, it neglects such factors as, e.g., nonparabolicity of the valence band, strain induced removal of degeneracy of the light- and heavy-hole bands, and possible contribution due to holes from the spin-orbit split valence band. This approach as well as the effective mass parameter used corresponds to the approximation frequently made, e.g., in the analysis of the ordinary Hall effect or conductivity of GaMnAs. The fully satisfactory theoretical model for the thermoelectric effects in heavily p-type doped GaMnAs should, apart from the realistic description of its complicated valence band, take also into account the modification of electronic valence band states close to the metal-insulator transition in the presence of p-d exchange interaction. To our knowledge, such a theoretical model is not available yet.

We found the Fermi level located rather deep below the top of the valence band, i.e. in agreement with the models of the electronic band structure of GaMnAs adopted in theoretical calculations of carrier induced ferromagnetism, spin-dependent tunnelling, and other magnetotransport and magneto-optical experiments [1, 20, 38, 39]. We note also that the dependence of the Fermi level in GaMnAs on Mn content obtained in our work is qualitatively very similar to the dependence determined being based on the photoemission experiments. However, the two results differ with respect to the absolute position of the Fermi level, which in photoemission experiments was found at (or just above) the top of the valence band [40]. In our work, the position of the Fermi level is given with respect to the top of the valence band, i.e., the edge of the energy range in which conducting hole states are available in GaAs. Although certain distortion of the density of states of GaMnAs in this range of energies is inevitable and this reference point may require some correction, we expect that the qualitative picture should not change.

We also note that the linear (\( aT + b \)) extrapolation of the temperature dependence of the thermoelectric power of GaMnAs from high temperatures to \( T = 0 \) K shows a negative value of the parameter \( b \) (\( b = -10(20)(\mu V/K) \)). Therefore, the experimental value of the diffusion contribution to the thermoelectric power should be determined rather from the slope of the linear part of \( a(T) \) plot than from the value of thermoelectric power at a given temperature [36]. This behavior found in GaMnAs is in contrast to thermoelectric power studies, e.g., of \( p\)-PbSnMnTe [41] degenerate ferromagnetic semiconductor and other nonmagnetic semiconducting and metallic materials, for which the linear dependence is usually observed down to liquid helium temperatures [42, 43]. The physical origin of this temperature independent negative contribution to the thermoelectric power of GaMnAs is likely to be the exchange thermoelectric power proposed by Kondo [35] as will be discussed in Section 3.2.1.
3.2. Thermoelectric power at low temperatures

3.2.1. Paramagnetic region

In diluted magnetic semiconducting and metallic systems with strong \textit{sp-d} exchange coupling the special, peculiar mechanism of the additional thermoelectric power is expected. It stems from the spin dependent scattering of carriers on magnetic ions. The full analysis of the influence of these mechanisms on the resistivity and the thermoelectric power was given by Kondo [35]. This, the so-called exchange thermoelectric power is only weakly temperature dependent and was found in Kondo systems together with the well known effect of logarithmic resistance enlargement at temperature decreasing after a minimum. Although, quantitatively, the theory of Kondo is valid only for the limit of extreme dilution, for systems with higher (but paramagnetic) concentration of magnetic ions the extension of this theory was proposed [35] with the following expression for the temperature dependence of the exchange thermoelectric power:

\[ \alpha_{\text{ex}}(T) = \frac{\alpha_0}{T + T_0}, \]

where \[\alpha_0 = 4\pi^2 \frac{k_B}{q} D^2 (E_F) I_{pd} V \frac{\rho_{\text{ex}}}{\rho}.\] (2)

Here \( D(E_F) \) is the density of states at the Fermi level, \( I_{pd} \) is the \textit{p-d} exchange integral between the carriers and the magnetic centres, \( V \) is the nonmagnetic scattering potential and \( \rho_{\text{ex}}/\rho \) is the ratio of the exchange part to the total resistivity. \( T_0 \) is a material parameter that is independent of temperature and is only weakly dependent on the concentration of magnetic ions. In the limit of very low concentration of Mn ions, \( T_0 \) is the Kondo temperature. The estimation of \( \alpha_0 \) with following parameters corresponding to GaMnAs: \( D(E_F) = 8 \times 10^{21} \text{ eV}^{-1} \text{cm}^{-3}, \) \( I_{pd} = -1 \text{ eV}, \) \( V = 1 \text{ eV}, \) and \( \rho_{\text{ex}}/\rho = 1/4 \) gives \( \alpha_0 = -20 \mu\text{V/K}. \)

For the analysis of the temperature dependence of thermoelectric power in metallic GaMnAs samples in the entire (paramagnetic) range of temperatures, we use the following expression:

\[ \alpha = \alpha_{\text{diff}} + \alpha_{\text{ex}} = b T + \alpha_0 \frac{T}{T + T_0}, \] (3)

where the first term is due to the diffusion contribution to the thermoelectric power and the second is due to the exchange contribution.

The example of the comparison of the model calculations and the experimental data is presented in Fig. 7. The best fit was achieved for the parameters \( \alpha_0 = -80 \mu\text{V/K}, \) \( T_0 = 150 \text{ K}, \) which are of correct order of magnitude. As expected, the incorporation of the exchange (Kondo) contribution explains the negative offset value of the thermoelectric power discussed above as well as qualitatively reproduces the very weak temperature dependence observed at low temperatures.

Fig. 6. Low temperature behavior of the thermoelectric power in GaMnAs layer (A268) exhibiting metallic conductivity. The solid line presents the contribution expected from the Kasuya model.

Fig. 7. Temperature dependence of the thermoelectric power in GaMnAs layer in a broad temperature range. The lines show fitting by theoretical model involving diffusion, paramagnetic Kondo, and ferromagnetic Kasuya contributions.
It should be noted that the Pb$_{0.16}$Sn$_{0.72}$Mn$_{0.12}$Te specimens, which manifest a ferromagnetic transition [44], do not demonstrate the exchange contribution to the thermoelectric power. In our opinion, this can be a result of the following reasons. Contrary to the PbSnMnTe system, GaMnAs compounds are highly doped compensated semiconductors, where, owing to their growing under non-equilibrium conditions of MBE, a lot of defects is created [42]. Here, one may expect for the Kondo mechanism to be realized, which would result in the exchange interaction between current carriers and isolated centers, i.e. in the appearance of the $\alpha_{ex}$ component. Simultaneously, provided that the ferromagnetic ordering takes place, the component $\alpha_{FM}$ which describes the interaction between current carriers and the molecular field of magnetic clusters (the Kasuya mechanism) appears.

### 3.2.2. Ferromagnetic region

Below the ferromagnetic transition temperature, the additional contribution to the thermoelectric power is due to appearance of the exchange splitting of the band states in metals or semiconductors. This ferromagnetic contribution to the thermoelectric power, $\alpha_{FM}$, is described by the Kasuya model of thermoelectric effects in metallic systems with the $sp$-$d$ exchange coupling [34]. It is based on the solution of the Boltzmann equation taking into account two effects originating from the $sp$-$d$ exchange interaction between the magnetic ions and the conducting carriers: (1) the exchange splitting of the conduction band states and (2) the spin-dependent carrier scattering. In contrast to the model of Kondo, the Kasuya contribution is nonzero only in the vicinity of the Curie temperature. The equation for the thermoelectric power below the Curie temperature accordingly to [34]:

$$\alpha_0 = \alpha_{dif} + \alpha_{FM} = \frac{\pi^2 k_B^2 T}{3 q E_F} (r + 3/2) - FA(w) J_2(w), \quad (4)$$

where $F$ is a (temperature independent) material parameter depending, in particular, on the third power of the $p$-$d$ exchange constant ($F \sim 13$) and:

$$J_2(w) = \left( J + \frac{2 J + 1}{e^{(2 J + 1) w} - 1} - \frac{1}{e^w - 1} \right), \quad (5)$$

$$w = \frac{H_m I_z}{k_B T} \quad \text{and} \quad H_m = \frac{3 k_B T_0}{J (J + 1)}.$$

Here $J$ is the quantum number of the total angular momentum of magnetic impurity, and for Mn$^{2+}$ ($s = 5/2$) ions in GaMnAs we take $J = 5/2$. $H_m$ is the molecular field parameter directly proportional to the paramagnetic Curie temperature $T_0$. Fig. 6 presents the comparison of the Kasuya model and the ferromagnetic contribution observed in GaMnAs layer A268 with 3 at.% Mn. In the calculations, the ferromagnetic Curie temperature obtained from the magnetic susceptibility measurements was used. Despite the model character of the calculation as well as some contribution to the thermoelectric power expected also above the Curie temperature, the qualitative agreement is achieved.

Finally, we would like to address the problem of the physical justification of using the additive diffusion, paramagnetic Kondo and ferromagnetic Kasuya contributions for the description of the thermoelectric power in GaMnAs layers in the entire temperature range discussed. The key point is that at low temperatures all three contributions are needed to qualitatively reproduce the experimentally observed behavior. At the same time, the temperature regions of applicability of the theoretical models by Kondo (only for paramagnetic case) and Kasuya (nonzero contribution only below $T_c$) are different. Although the theoretical model that would unify the two approaches both in the paramagnetic and ferromagnetic range of temperatures is not available, it probably could not be reduced to the simple addition of both contributions. In this respect, we would like to point out that there is a possibility that all these contributions are observed in the entire temperature range studied because of the effect of electronic separation, which produces in GaMnAs layers both ferromagnetic (sufficiently high hole concentration) and paramagnetic (deficient hole concentration) regions with relative volume fraction varying in dependency on the Mn content, doping, and growth conditions. The possibility of such an effect is currently discussed, e.g., in manganites but it was originally suggested for magnetic semiconductors with relatively low carrier concentration [45]. The existence of such effect would also explain our experimental findings that, between the limiting cases of metallic and highly resistive layers, in fact, there exists a continuity of low temperature behaviors of thermoelectric power in GaMnAs. It probably reflects the changes in the relative volume of metallic and non-metallic regions of the layer.

### 3.2.3. Metallic versus non-metallic layers

Although at high temperatures there appears no qualitative difference between the temperature dependence of the thermoelectric power of metallic and nonmetallic layers of GaMnAs, their low temperature thermoelectric properties qualitatively differ. For layers exhibiting metallic type of conductivity, the low temperature behavior of thermoelectric power is described by the superposition of ferromagnetic Kasuya contribution and paramagnetic exchange thermoelectric power, as it has been discussed above. For layers exhibiting nonmetallic type of conductivity at low temperatures, the thermoelectric power strongly increases with decreasing temperature and the $\Delta \alpha \sim AE / k_B T$ type of behavior is found. This type of temperature dependence of thermoelectric power is observed, e.g., in the systems with constant range hopping conduction [32].
Based on the experimentally determined slope of the parameter only slightly dependent on temperature \[\text{vs } 1/\text{T}\] for monocrystalline layers of Ga\(_{1-x}\)Mn\(_x\)As grown by low-energy molecular beam technique (on GaAs (001) semi-insulating substrates) with Mn content in the range \((0.015 \leq x \leq 0.06)\) covering both the materials with paramagnetic and ferromagnetic behavior. At low temperatures, we also observe a temperature independent contribution to the thermoelectric power assigned to the exchange thermoelectric power (Kondo mechanism) obliged to exchange interaction of current carriers with paramagnetic centers (Mn\(^{2+}\)). In GaMnAs samples exhibiting insulating properties, the additional \(\Delta E / k_B T\)-type contribution to the thermoelectric power at low temperatures is observed and attributed to hopping conduction mechanisms.

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